

# FSBB30CH60CT

# Motion SPM® 3 Series

### **Features**

- UL Certified No. E209204 (UL1557)
- 600 V 30 A 3-Phase IGBT Inverter with Integral Gate Drivers and Protection
- · Low-Loss, Short-Circuit Rated IGBTs
- Very Low Thermal Resistance Using Al<sub>2</sub>O<sub>3</sub> DBC Substrate
- Built-In Bootstrap Diodes and Dedicated Vs Pins Simplify PCB Layout
- Separate Open-Emitter Pins from Low-Side IGBTs for Three-Phase Current Sensing
- Single-Grounded Power Supply
- Isolation Rating: 2500 V<sub>rms</sub> / min.

# **Applications**

• Motion Control - Home Appliance / Industrial Motor

# **Related Resources**

AN-9044 - Motion SPM® 3 Series Users Guide



# **General Description**

FSBB30CH60CT is an advanced Motion SPM® 3 module providing a fully-featured, high-performance inverter output stage for AC Induction, BLDC, and PMSM motors. These modules integrate optimized gate drive of the built-in IGBTs to minimize EMI and losses, while also providing multiple on-module protection features including under-voltage lockouts, over-current shutdown, and fault reporting. The built-in, high-speed HVIC requires only a single supply voltage and translates the incoming logic-level gate inputs to the high-voltage, high-current drive signals required to properly drive the module's internal IGBTs. Separate negative IGBT terminals are available for each phase to support the widest variety of control algorithms.

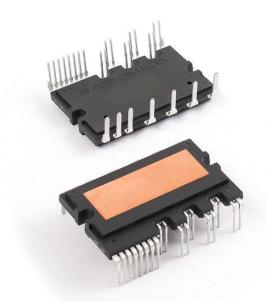


Figure 1. Package Overview

# **Package Marking and Ordering Information**

Device	Device Marking	Package	Packing Type	Quantity
FSBB30CH60CT	FSBB30CH60CT	SPMCC-027	Rail	10

# **Integrated Power Functions**

• 600 V - 30 A IGBT inverter for three-phase DC / AC power conversion (please refer to Figure 3)

# Integrated Drive, Protection, and System Control Functions

- For inverter high-side IGBTs: gate drive circuit, high-voltage isolated high-speed level shifting
   control circuit Under-Voltage Lock-Out Protection (UVLO)
   Note: Available bootstrap circuit example is given in Figures 12 and 13.
- For inverter low-side IGBTs: gate drive circuit, Short-Circuit Protection (SCP)
  control supply circuit Under-Voltage Lock-Out Protection (UVLO)
- Fault signaling: corresponding to UVLO (low-side supply) and SC faults
- Input interface: active-HIGH interface, works with 3.3 / 5 V logic, Schmitt-trigger input

# **Pin Configuration**

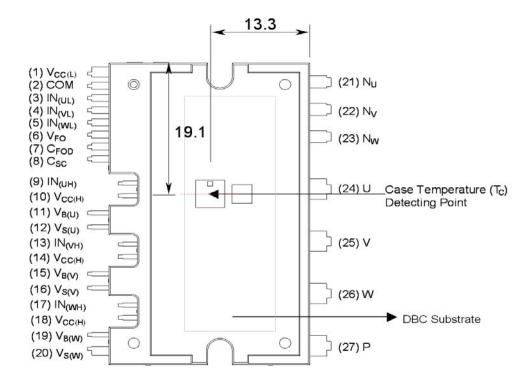


Figure 2. Top View

# **Pin Descriptions**

Pin Number	Pin Name	Pin Description
1	V <sub>CC(L)</sub>	Low-Side Common Bias Voltage for IC and IGBTs Driving
2	COM	Common Supply Ground
3	IN <sub>(UL)</sub>	Signal Input for Low-Side U-Phase
4	IN <sub>(VL)</sub>	Signal Input for Low-Side V-Phase
5	IN <sub>(WL)</sub>	Signal Input for Low-Side W-Phase
6	V <sub>FO</sub>	Fault Output
7	C <sub>FOD</sub>	Capacitor for Fault Output Duration Selection
8	C <sub>SC</sub>	Capacitor (Low-Pass Filter) for Short-Circuit Current Detection Input
9	IN <sub>(UH)</sub>	Signal Input for High-Side U-Phase
10	V <sub>CC(H)</sub>	High-Side Common Bias Voltage for IC and IGBTs Driving
11	V <sub>B(U)</sub>	High-Side Bias Voltage for U-Phase IGBT Driving
12	V <sub>S(U)</sub>	High-Side Bias Voltage Ground for U-Phase IGBT Driving
13	IN <sub>(VH)</sub>	Signal Input for High-Side V-Phase
14	V <sub>CC(H)</sub>	High-Side Common Bias Voltage for IC and IGBTs Driving
15	V <sub>B(V)</sub>	High-Side Bias Voltage for V-Phase IGBT Driving
16	V <sub>S(V)</sub>	High-Side Bias Voltage Ground for V Phase IGBT Driving
17	IN <sub>(WH)</sub>	Signal Input for High-Side W-Phase
18	V <sub>CC(H)</sub>	High-Side Common Bias Voltage for IC and IGBTs Driving
19	V <sub>B(W)</sub>	High-Side Bias Voltage for W-Phase IGBT Driving
20	V <sub>S(W)</sub>	High-Side Bias Voltage Ground for W-Phase IGBT Driving
21	N <sub>U</sub>	Negative DC-Link Input for U-Phase
22	N <sub>V</sub>	Negative DC-Link Input for V-Phase
23	N <sub>W</sub>	Negative DC-Link Input for W-Phase
24	U	Output for U-Phase
25	V	Output for V-Phase
26	W	Output for W-Phase
27	Р	Positive DC-Link Input

# **Internal Equivalent Circuit and Input/Output Pins**

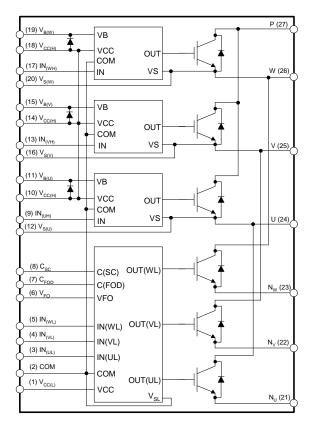


Figure 3. Internal Block Diagram

#### 1st Notes:

- 1. Inverter low-side is composed of three IGBTs, freewheeling diodes for each IGBT, and one control IC. It has gate drive and protection functions.
- 2. Inverter power side is composed of four inverter DC-link input terminals and three inverter output terminals.
- 3. Inverter high-side is composed of three IGBTs, freewheeling diodes, and three drive ICs for each IGBT.

# **Absolute Maximum Ratings** ( $T_J = 25$ °C, unless otherwise specified.)

# **Inverter Part**

Symbol	Parameter	Conditions	Rating	Unit
V <sub>PN</sub>	Supply Voltage	Applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>	450	V
V <sub>PN(Surge)</sub>	Supply Voltage (Surge)	Applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>	500	V
V <sub>CES</sub>	Collector - Emitter Voltage		600	V
± I <sub>C</sub>	Each IGBT Collector Current	T <sub>C</sub> = 25°C, T <sub>J</sub> ≤ 150°C	30	Α
± I <sub>CP</sub>	Each IGBT Collector Current (Peak)	$T_C$ = 25°C, $T_J \le$ 150°C, Under 1 ms Pulse Width	60	А
P <sub>C</sub>	Collector Dissipation	T <sub>C</sub> = 25°C per Chip	78	W
T <sub>J</sub>	Operating Junction Temperature	(2nd Note 1)	- 40 ~ 150	°C

#### 2nd Notes

# **Control Part**

Symbol	Parameter	Conditions	Rating	Unit
V <sub>CC</sub>	Control Supply Voltage	Applied between V <sub>CC(H)</sub> , V <sub>CC(L)</sub> - COM	20	V
$V_{BS}$	High-Side Control Bias Voltage	Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ - $V_{S(W)}$	20	V
$V_{IN}$	Input Signal Voltage	$\begin{array}{cccccccccccccccccccccccccccccccccccc$	-0.3 ~ V <sub>CC</sub> + 0.3	V
V <sub>FO</sub>	Fault Output Supply Voltage	Applied between V <sub>FO</sub> - COM	-0.3 ~ V <sub>CC</sub> + 0.3	V
I <sub>FO</sub>	Fault Output Current	Sink Current at V <sub>FO</sub> pin	5	mA
V <sub>SC</sub>	Current-Sensing Input Voltage	Applied between C <sub>SC</sub> - COM	-0.3 ~ V <sub>CC</sub> + 0.3	V

# **Bootstrap Diode Part**

Symbol	Parameter	Conditions	Rating	Unit
$V_{RRM}$	Maximum Repetitive Reverse Voltage		600	V
I <sub>F</sub>	Forward Current	$T_C = 25^{\circ}C, T_J \le 150^{\circ}C$	0.5	Α
I <sub>FP</sub>	Forward Current (Peak)	$T_C = 25^{\circ}C$ , $T_J \le 150^{\circ}C$ Under 1 ms Pulse Width	2.0	Α
T <sub>J</sub>	Operating Junction Temperature		-40 ~ 150	°C

# **Total System**

Symbol	Parameter Conditions		Rating	Unit
V <sub>PN(PROT)</sub>	Self-Protection Supply Voltage Limit (Short-Circuit Protection Capability)	$V_{CC} = V_{BS} = 13.5 \sim 16.5 \text{ V}$ $T_J = 150^{\circ}\text{C}$ , Non-Repetitive, < 2 $\mu$ s	400	V
T <sub>C</sub>	Module Case Operation Temperature	$-40$ °C $\leq$ T <sub>J</sub> $\leq$ 150°C, See Figure 2	-40 ~ 125	°C
T <sub>STG</sub>	Storage Temperature		-40 ~ 125	°C
V <sub>ISO</sub>	Isolation Voltage	60 Hz, Sinusoidal, AC 1 Minute, Connect Pins to Heat Sink Plate	2500	V <sub>rms</sub>

# **Thermal Resistance**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
R <sub>th(j-c)Q</sub>	Junction to Case Thermal Resistance	Inverter IGBT Part (per 1 / 6 module)	-	-	1.60	°C / W
R <sub>th(j-c)F</sub>		Inverter FWDi Part (per 1 / 6 module)	-	-	2.40	°C/W

#### 2nd Notes

<sup>1.</sup> The maximum junction temperature rating of the power chips integrated within the Motion SPM $^{6}$  3 product is 150°C (at T<sub>C</sub>  $\leq$  125°C).

<sup>2.</sup> For the measurement point of case temperature ( $T_{\mbox{\scriptsize C}}$ ), please refer to Figure 2.

# **Electrical Characteristics** ( $T_J = 25$ °C, unless otherwise specified.)

# **Inverter Part**

S	ymbol	Parameter	Condi	tions	Min.	Тур.	Max.	Unit
V	CE(SAT)	Collector - Emitter Saturation $V_{CC} = V_{BS} = 15 \text{ V}$ $I_{C} = 30 \text{ A}, T_{J} = 25^{\circ}\text{C}$ Voltage $V_{IN} = 5 \text{ V}$		-	2.0	2.6	V	
	V <sub>F</sub>	FWDi Forward Voltage	V <sub>IN</sub> = 0 V	I <sub>F</sub> = 30 A, T <sub>J</sub> = 25°C	-	1.9	2.5	V
HS	t <sub>ON</sub>	Switching Times	$V_{PN} = 300 \text{ V}, V_{CC} = V_{B}$	<sub>S</sub> = 15 V	-	0.75	-	μS
	t <sub>C(ON)</sub>		$I_C = 30 \text{ A}$	tive Load	-	0.2	-	μS
	t <sub>OFF</sub>		$V_{IN} = 0 \text{ V} \leftrightarrow 5 \text{ V}$ , Inductive Load (2nd Note 3)		-	0.4	-	μS
	t <sub>C(OFF)</sub>				-	0.1	-	μS
	t <sub>rr</sub>				-	0.1	-	μS
LS	t <sub>ON</sub>		$V_{PN} = 300 \text{ V}, V_{CC} = V_{B}$	<sub>S</sub> = 15 V	-	0.55	-	μS
	t <sub>C(ON)</sub>		$I_C = 30 \text{ A}$ $V_{IN} = 0 \text{ V} \leftrightarrow 5 \text{ V}$ , Induc	tive Load	-	0.35	-	μS
	t <sub>OFF</sub>		(2nd Note 3)	iive Load	-	0.4	-	μS
	t <sub>C(OFF)</sub>		,		-	0.1	-	μS
	t <sub>rr</sub>				-	0.1	-	μS
	I <sub>CES</sub> Collector - Emitter Leakage Current		V <sub>CE</sub> = V <sub>CES</sub>		-	-	1	mA

#### 2nd Notes:

### **Control Part**

Symbol	Parameter	Co	nditions	Min.	Тур.	Max.	Unit
I <sub>QCCL</sub>	Quiescent V <sub>CC</sub> Supply Current	V <sub>CC</sub> = 15 V IN <sub>(UL, VL, WL)</sub> = 0 V	V <sub>CC(L)</sub> - COM	-	-	23	mA
I <sub>QCCH</sub>		$V_{CC} = 15 \text{ V}$ $IN_{(UH, VH, WH)} = 0 \text{ V}$	V <sub>CC(H)</sub> - COM	ı	-	600	μА
$I_{QBS}$	Quiescent V <sub>BS</sub> Supply Current	$V_{BS} = 15 \text{ V}$ $IN_{(UH, VH, WH)} = 0 \text{ V}$	$ \begin{vmatrix} V_{B(U)} - V_{S(U)}, V_{B(V)} - V_{S(V)}, \\ V_{B(W)} - V_{S(W)} \end{vmatrix} $	ı	-	500	μА
$V_{FOH}$	Fault Output Voltage	V <sub>SC</sub> = 0 V, V <sub>FO</sub> Circu	uit: 4.7 kΩ to 5 V Pull-up	4.5	-	-	V
$V_{FOL}$		V <sub>SC</sub> = 1 V, V <sub>FO</sub> Circu	uit: 4.7 kΩ to 5 V Pull-up	1	-	0.8	٧
V <sub>SC(ref)</sub>	Short-Circuit Current Trip Level	V <sub>CC</sub> = 15 V (2nd Note 4)		0.45	0.50	0.55	V
TSD	Over-Temperature Protection	Temperature at LVIC		-	160	-	°C
ΔTSD	Over-Temperature Protection Hysterisis	Temperature at LVIC		-	5	-	°C
UV <sub>CCD</sub>	Supply Circuit	Detection Level		10.7	11.9	13.0	V
UV <sub>CCR</sub>	Under-Voltage Protection	Reset Level		11.2	12.4	13.4	٧
UV <sub>BSD</sub>		Detection Level		10	11	12	V
UV <sub>BSR</sub>		Reset Level		10.5	11.5	12.5	V
t <sub>FOD</sub>	Fault-Out Pulse Width	C <sub>FOD</sub> = 33 nF (2nd Note 5)		1.0	1.8	-	ms
V <sub>IN(ON)</sub>	ON Threshold Voltage	Applied between IN <sub>(UH)</sub> , IN <sub>(VH)</sub> , IN <sub>(WH)</sub> , IN <sub>(UL)</sub> ,		2.8	-	-	V
V <sub>IN(OFF)</sub>	OFF Threshold Voltage	IN <sub>(VL)</sub> , IN <sub>(WL)</sub> - COM		-	-	0.8	V

#### 2nd Notes:

<sup>3.</sup>  $t_{\text{ON}}$  and  $t_{\text{OFF}}$  include the propagation delay of the internal drive IC.  $t_{\text{C(ON)}}$  and  $t_{\text{C(OFF)}}$  are the switching time of IGBT itself under the given gate driving condition internally. For the detailed information, please see Figure 4.

<sup>4.</sup> Short-circuit protection is functioning only at the low-sides.

<sup>5.</sup> The fault-out pulse width  $t_{FOD}$  depends on the capacitance value of  $C_{FOD}$  according to the following approximate equation:  $C_{FOD} = 18.3 \times 10^{-6} \times t_{FOD}$  [F]

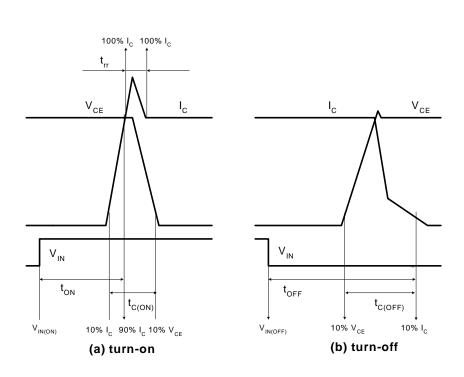


Figure 4. Switching Time Definition

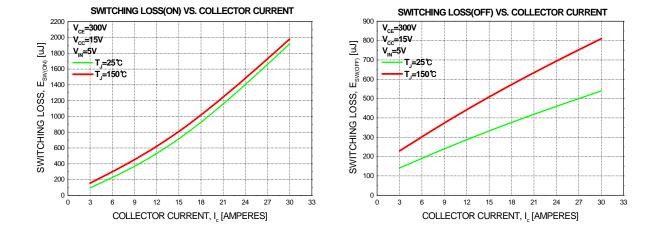


Figure 5. Switching Loss Characteristics (Typical)

# **Bootstrap Diode Part**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
V <sub>F</sub>	Forward Voltage	I <sub>F</sub> = 0.1 A, T <sub>C</sub> = 25°C	-	2.5	-	V
t <sub>rr</sub>	Reverse-Recovery Time	I <sub>F</sub> = 0.1 A, T <sub>C</sub> = 25°C	-	80	-	ns

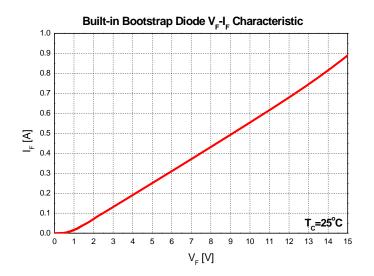


Figure 6. Built-in Bootstrap Diode Characteristics

#### 2nd Notes:

6. Built-in bootstrap diode includes around 15  $\,\Omega\,$  resistance characteristic.

# **Recommended Operating Conditions**

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
$V_{PN}$	Supply Voltage	Applied between P - N <sub>U</sub> , N <sub>V</sub> , N <sub>W</sub>	-	300	400	V
V <sub>CC</sub>	Control Supply Voltage	Applied between V <sub>CC(H)</sub> , V <sub>CC(L)</sub> - COM	13.5	15.0	16.5	V
$V_{BS}$	High-Side Bias Voltage	Applied between $V_{B(U)}$ - $V_{S(U)}$ , $V_{B(V)}$ - $V_{S(V)}$ , $V_{B(W)}$ - $V_{S(W)}$	13.0	15.0	18.5	V
$dV_{CC}$ / $dt$ , $dV_{BS}$ / $dt$	Control Supply Variation		-1	-	1	V / μs
t <sub>dead</sub>	Blanking Time for Preventing Arm-Short	Each Input Signal	2	-	-	μS
f <sub>PWM</sub>	PWM Input Signal	$-40^{\circ}C \le T_C \le 125^{\circ}C$ , $-40^{\circ}C \le T_J \le 150^{\circ}C$	-	-	20	kHz
$V_{SEN}$	Voltage for Current Sensing	Applied between $N_U$ , $N_V$ , $N_W$ - COM (Including Surge Voltage)	-4		4	V

# **Mechanical Characteristics and Ratings**

Parameter	Conditions			Тур.	Max.	Unit
Mounting Torque	Mounting Screw: M3	Recommended 0.62 N•m	0.51	0.62	0.80	N•m
Device Flatness		See Figure 7	0	-	+150	μm
Weight			-	15.00	-	g

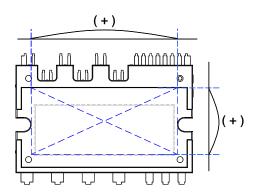
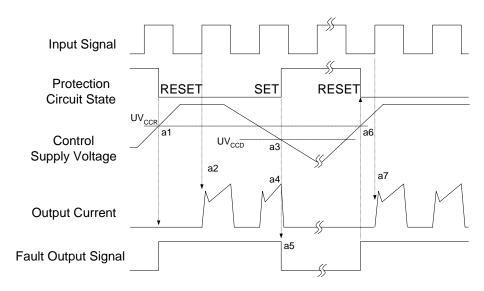


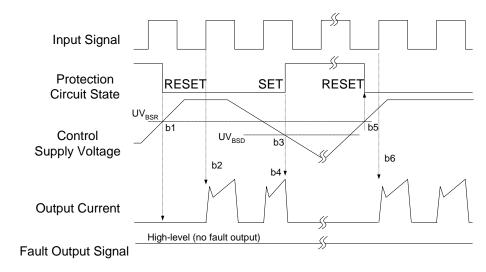
Figure 7. Flatness Measurement Position

### **Time Charts of Protective Function**



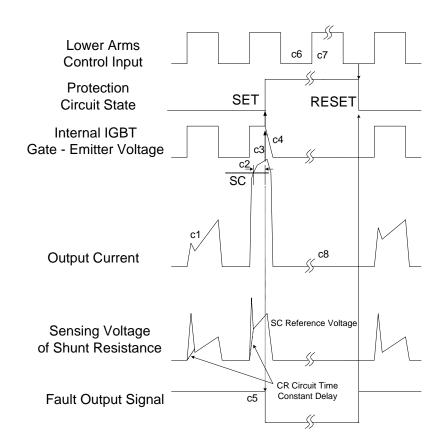
- a1 : Control supply voltage rises: after the voltage rises UV<sub>CCR</sub>, the circuits start to operate when next input is applied.
- a2: Normal operation: IGBT ON and carrying current.
- a3 : Under-voltage detection (UV<sub>CCD</sub>).
- a4: IGBT OFF in spite of control input condition.
- a5 : Fault output operation starts.
- a6 : Under-voltage reset (UV $_{CCR}$ ).
- a7: Normal operation: IGBT ON and carrying current.

Figure 8. Under-Voltage Protection (Low-Side)



- b1 : Control supply voltage rises: after the voltage reaches UV<sub>BSR</sub>, the circuits start to operate when next input is applied.
- b2: Normal operation: IGBT ON and carrying current.
- b3: Under-voltage detection (UV<sub>BSD</sub>).
- b4: IGBT OFF in spite of control input condition, but there is no fault output signal.
- b5 : Under-voltage reset (UV<sub>BSR</sub>).
- b6: Normal operation: IGBT ON and carrying current.

Figure 9. Under-Voltage Protection (High-Side)



(with the external shunt resistance and CR connection)

- c1: Normal operation: IGBT ON and carrying current.
- c2 : Short-circuit current detection (SC trigger).
- c3: Hard IGBT gate interrupt.
- c4: IGBT turns OFF.
- c5 : Fault output timer operation starts: the pulse width of the fault output signal is set by the external capacitor C<sub>FO</sub>.
- c6: Input "LOW": IGBT OFF state.
- c7 : Input "HIGH": IGBT ON state, but during the active period of fault output, the IGBT doesn't turn ON.
- c8: IGBT OFF state.

Figure 10. Short-Circuit Protection (Low-Side Operation Only)

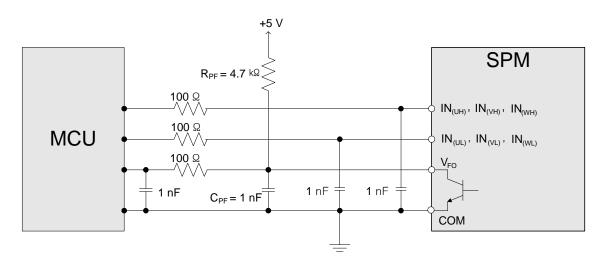


Figure 11. Recommended MCU I/O Interface Circuit

#### 3rd Notes:

- 1. RC coupling at each input might change depending on the PWM control scheme in the application and the wiring impedance of the application's printed circuit board. The input signal section of the Motion SPM<sup>®</sup> 3 product integrates a 5 kΩ (typ.) pull-down resistor. Therefore, when using an external filtering resistor, please pay attention to the signal voltage drop at input terminal.
- 2. The logic input works with standard CMOS or LSTTL outputs.

### These values depend on PWM control algorithm.

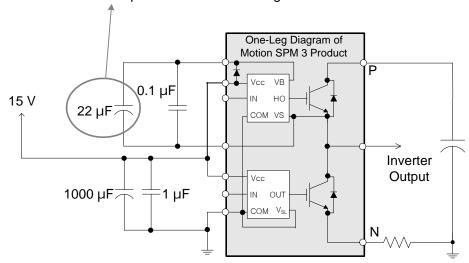


Figure 12. Recommended Bootstrap Operation Circuit and Parameters

#### 3rd Notes:

3. The ceramic capacitor placed between V<sub>CC</sub> - COM should be over 1 µF and mounted as close to the pins of the Motion SPM 3 product as possible.

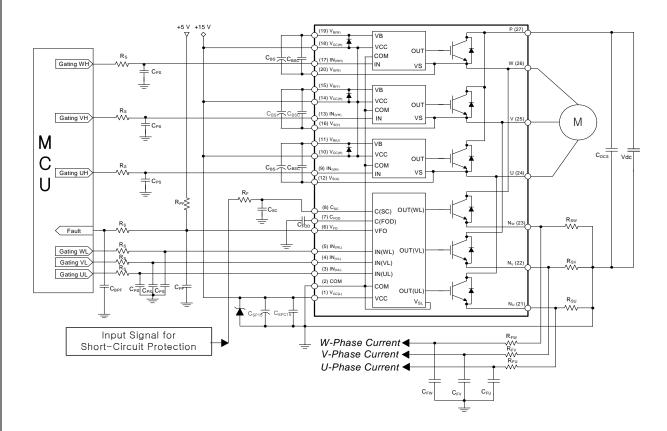
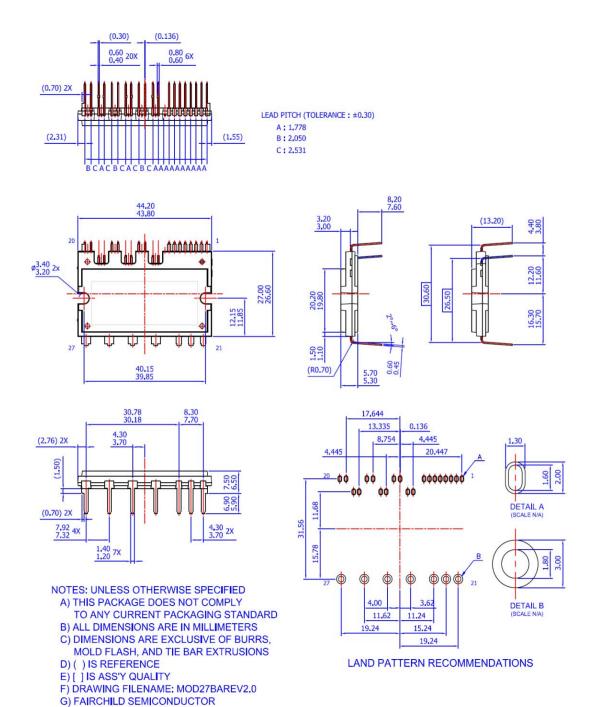


Figure 13. Typical Application Circuit

#### 4th Notes:

- 1. To avoid malfunction, the wiring of each input should be as short as possible (less than 2 3cm).
- 2. By virtue of integrating an application-specific type of HVIC inside the Motion SPM® 3 product, direct coupling to MCU terminals without any optocoupler or transformer isolation is possible.
- 3.  $V_{FO}$  output is open-collector type. This signal line should be pulled up to the positive side of the 5 V power supply with approximately 4.7 k $\Omega$  resistance (please refer to Figure11).
- 4.  $C_{\mbox{\footnotesize{SP15}}}$  of around seven times larger than bootstrap capacitor  $C_{\mbox{\footnotesize{BS}}}$  is recommended.
- 5.  $V_{FO}$  output pulse width should be determined by connecting an external capacitor ( $C_{FOD}$ ) between  $C_{FOD}$  (pin 7) and COM (pin 2). (Example: if  $C_{FOD} = 33$  nF, then  $t_{FO} = 1.8$  ms (typ.)) Please refer to the 2nd note 5 for calculation method.
- 6. Input signal is active-HIGH type. There is a 5 k $\Omega$  resistor inside the IC to pull down each input signal line to GND. RC coupling circuits should be used to prevent input signal oscillation.  $R_S C_{PS}$  time constant should be selected in the range 50 ~ 150 ns.  $C_{PS}$  should not be less than 1 nF (recommended  $R_S = 100 \ \Omega$ ,  $C_{PS} = 1 \ nF$ ).
- 7. To prevent errors of the protection function, the wiring around  $R_{\text{F}}$  and  $C_{\text{SC}}$  should be as short as possible.
- 8. In the short-circuit protection circuit, please select the  $R_F C_{SC}$  time constant in the range 1.5 ~ 2.0  $\mu s$
- 9. Each capacitor should be mounted as close to the pins of the Motion SPM 3 product as possible.
- 10. To prevent surge destruction, the wiring between the smoothing capacitor and the P & GND pins should be as short as possible. The use of a high-frequency non-inductive capacitor of around 0.1 ~ 0.22 µF between the P & GND pins is recommended.
- 11. Relays are used in almost every systems of electrical equipment in home appliances. In these cases, there should be sufficient distance between the MCU and the relays.
- 12.  $C_{SPC15}$  should be over 1  $\mu F$  and mounted as close to the pins of the Motion SPM 3 product as possible.

# **Detailed Package Outline Drawings**



Package drawings are provided as a service to customers considering Fairchild components. Drawings may change in any manner without notice. Please note the revision and/or data on the drawing and contact a FairchildSemiconductor representative to verify or obtain the most recent revision. Package specifications do not expand the terms of Fairchild's worldwide therm and conditions, specifically the the warranty therein, which covers Fairchild products.

Always visit Fairchild Semiconductor's online packaging area for the most recent package drawings:

http://www.fairchildsemi.com/dwq/MO/MOD27BA.pdf





#### **TRADEMARKS**

The following includes registered and unregistered trademarks and service marks, owned by Fairchild Semiconductor and/or its global subsidiaries, and is not intended to be an exhaustive list of all such trademarks.

F-PFS" AX-CAP FRFET®

Global Power Resource<sup>SM</sup> BitSiC™ GreenBridge™ Build it Now™

CorePLUS™ Green FPS™ CorePOWER™ Green FPS™ e-Series™

**CROSSVOLT™** Gmax™ CTL™ **GTO™** IntelliMAXTM Current Transfer Logic™ DEUXPEED<sup>®</sup> ISOPLANAR™

Dual Cool™ Making Small Speakers Sound Louder

EcoSPARK® and Better™ EfficientMax™ MegaBuck<sup>TI</sup> MICROCOUPLER™ ESBC<sup>TM</sup>

MicroFET<sup>11</sup> MicroPak™ Fairchild<sup>®</sup> MicroPak2™ Fairchild Semiconductor® MillerDrive™ FACT Quiet Series™ MotionMax™ mWSaver FAST®

OptoHiT™ FastvCore™ OPTOLOGIC® FETBench™ **OPTOPLANAR**<sup>®</sup> **FPS™** 

PowerTrench® PowerXS™

Programmable Active Droop™

OFFT OSTM Quiet Series™ RapidConfigure™

Saving our world, 1mW/W/kW at a time™

SignalWise\*\* SmartMax™ SMART START™

Solutions for Your Success™

SPM® STEALTH\* SuperFET® SuperSOT™-3 SuperSOT™-6 SuperSOT™-8 SupreMOS® SyncFET™

Sync-Lock™ SYSTEM STERNER TinyBoost<sup>®</sup> TinyBuck TinyCalc™ TinyLogic<sup>®</sup> TINYOPTO™ TinyPower<sup>TI</sup> TinyPWM™ TinyWire™ TranSiC™ TriFault Detect™ TRUECURRENT®\*

UHC Ultra FRFET™ UniFET™ VCX\*\* VisualMax™ VoltagePlus™ XS™

uSerDes™

#### DISCLAIMER

FAIRCHILD SEMICONDUCTOR RESERVES THE RIGHT TO MAKE CHANGES WITHOUT FURTHER NOTICE TO ANY PRODUCTS HEREIN TO IMPROVE RELIABILITY, FUNCTION, OR DESIGN. FAIRCHILD DOES NOT ASSUME ANY LIABILITY ARISING OUT OF THE APPLICATION OR USE OF ANY PRODUCT OR CIRCUIT DESCRIBED HEREIN; NEITHER DOES IT CONVEY ANY LICENSE UNDER ITS PATENT RIGHTS, NOR THE RIGHTS OF OTHERS. THESE SPECIFICATIONS DO NOT EXPAND THE TERMS OF FAIRCHILD'S WORLDWIDE TERMS AND CONDITIONS, SPECIFICALLY THE WARRANTY THEREIN, WHICH COVERS THESE PRODUCTS.

# LIFE SUPPORT POLICY

FAIRCHILD'S PRODUCTS ARE NOT AUTHORIZED FOR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS WITHOUT THE EXPRESS WRITTEN APPROVAL OF FAIRCHILD SEMICONDUCTOR CORPORATION.

#### As used herein:

- 1. Life support devices or systems are devices or systems which, (a) are intended for surgical implant into the body or (b) support or sustain life, and (c) whose failure to perform when properly used in accordance with instructions for use provided in the labeling, can be reasonably expected to result in a significant injury of the user.
- 2. A critical component in any component of a life support, device, or system whose failure to perform can be reasonably expected to cause the failure of the life support device or system, or to affect its safety or effectiveness.

### ANTI-COUNTERFEITING POLICY

Fairchild Semiconductor Corporation's Anti-Counterfeiting Policy. Fairchild's Anti-Counterfeiting Policy is also stated on our external website, www.fairchildsemi.com,

Counterfeiting of semiconductor parts is a growing problem in the industry. All manufacturers of semiconductor products are experiencing counterfeiting of their parts. Customers who inadvertently purchase counterfeit parts experience many problems such as loss of brand reputation, substandard performance, failed applications, and increased cost of production and manufacturing delays. Fairchild is taking strong measures to protect ourselves and our customers from the proliferation of counterfeit parts. Fairchild strongly encourages customers to purchase Fairchild parts either directly from Fairchild or from Authorized Fairchild Distributors who are listed by country on our web page cited above. Products customers buy either from Fairchild directly or from Authorized Fairchild Distributors are genuine parts, have full fraceability, meet Fairchild's quality standards for handling and storage and provide access to Fairchild's full range of up-to-date technical and product information. Fairchild and our Authorized Distributors will stand behind all warranties and will appropriately address any warranty issues that may arise. Fairchild will not provide any warranty coverage or other assistance for parts bought from Unauthorized Sources. Fairchild is committed to combat this global problem and encourage our customers to do their part in stopping this practice by buying direct or from authorized distributors.

### PRODUCT STATUS DEFINITIONS

<b>Datasheet Identification</b>	Product Status	Definition
Advance Information	Formative / In Design	Datasheet contains the design specifications for product development. Specifications may change in any manner without notice.
Preliminary	First Production	Datasheet contains preliminary data; supplementary data will be published at a later date. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve design.
No Identification Needed	Full Production	Datasheet contains final specifications. Fairchild Semiconductor reserves the right to make changes at any time without notice to improve the design.
Obsolete	Not In Production	Datasheet contains specifications on a product that is discontinued by Fairchild Semiconductor. The datasheet is for reference information only.

Rev. 166

<sup>\*</sup> Trademarks of System General Corporation, used under license by Fairchild Semiconductor.